Notice of References Cited Application/Control No. 10/647,725 Examiner Jason K. Lin Applicant(s)/Patent Under Reexamination DUFF ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,742,188	05-2004	Del Castillo, Leonardo	725/153
*	В	US-6,668,133	12-2003	Yuen et al.	386/83
	С	US-			
	D	US-			
	Ε	US-			
	F	US-			
	G	US-			
	Н	US-			
	-	US-			
	J	US-			
	К	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	EP 952734 A2	10-1999	European Patent	CHEN et al.	H04N 05/445
	0					
	Р					
	Q					
	R					
	S					
	Т					

NON-PATENT DOCUMENTS

	NON-FAIENT DOCUMENTS								
*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)							
	υ								
	٧								
	. w								
	×								

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.